



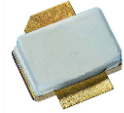
GaN 50V, 130W, 0.1-3.8GHz RF Power Transistor

STBV38130G2

Description

The STBV38130G2 is a 130watt, GaN HEMT, ideal for general applications from 0.1 to 3.8GHz. It can support CW, pulse or any modulated signal. There is no guarantee of performance when this part is used outside of stated frequencies.

- Typical Class AB performance 3.4-3.8GHz: (On application board with device soldered)



VdS= 50V, Idq=100mA, Vgs =-3.18V WCDMA-1C-PAR10.8							
Freq (MHz)	Pout (dBm)	CCDF (dB)	Ppeak (dBm)	Ppeak (W)	ACPR (dBc)	Gain (dB)	Efficiency (%)
3400	43	8.70	51.68	147.2	-38.8	13.8	23.8
3500		8.69	51.66	146.5	-39.1	14.5	24.1
3600		8.65	51.63	145.5	-38.4	14.8	25.0
3700		8.53	51.50	141.4	-37.8	14.9	26.5
3800		8.29	51.28	134.2	-37.1	14.6	28.3

Applications

- 5G, 4G wireless infrastructure
- S band power amplifier
- Test instruments
- Jammer

Important Note: Proper Biasing Sequence for GaN HEMT Transistors

Turning the device ON

- Set VGS to the pinch--off (VP) voltage, typically -5 V
- Turn on VDS to nominal supply voltage
- Increase VGS until IDS current is attained
- Apply RF input power to desired level

Turning the device OFF

- Turn RF power off
- Reduce VGS down to VP, typically -5 V
- Reduce VDS down to 0 V
- Turn off VGS

Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
Drain--Source Voltage	V _{DSS}	+200	Vdc
Gate--Source Voltage	V _{GS}	-8 to +0.5	Vdc
Operating Voltage	V _{DD}	55	Vdc
Maximum gate current	I _{gs}	16.8	mA
Storage Temperature Range	T _{stg}	-65 to +150	°C
Case Operating Temperature	T _C	+150	°C
Operating Junction Temperature	T _J	+225	°C

Table 2. Thermal Characteristics

Characteristic	Symbol	Value	Unit
Thermal Resistance, Junction to Case by FEA	R _{θJC}	2	°C /W



$T_C = 85^\circ\text{C}$, at $P_{avg}=25\text{W}$ WCDMA 1 carrier

Table 3. Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted)

DC Characteristics (measured on wafer prior to packaging)

Characteristic	Conditions	Symbol	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	$V_{GS}=-8\text{V}$; $I_{DS}=16.8\text{mA}$	V_{DSS}		200		V
Gate Threshold Voltage	$V_{DS}=10\text{V}$, $I_D=16.8\text{mA}$	$V_{GS(th)}$	-4	-3	-2	V
Gate Quiescent Voltage	$V_{DS}=50\text{V}$, $I_{DS}=150\text{mA}$, Measured in Functional Test	$V_{GS(Q)}$		-3.2		V

Ruggedness Characteristics

Characteristic	Conditions	Symbol	Min	Typ	Max	Unit
Load mismatch capability	3.6GHz, $P_{out}=130\text{W}$ pulse CW All phase, No device damages	VSWR		10:1		

3.4-3.8GHz

Typical performance

Figure 1: Efficiency and power gain as function of P_{out} (Measured on 3.4-3.8GHz application board)

$V_{DD} = 50\text{Vdc}$, $I_{DQ} = 100\text{mA}$, Pulse width=20us, duty cycle=20%

STBV38130G2 Class AB $V_{ds}=50\text{V}$, $I_{dq}=126.3\text{mA}$
PulseWidth= 20us, DutyCycle= 10%, DEMO1

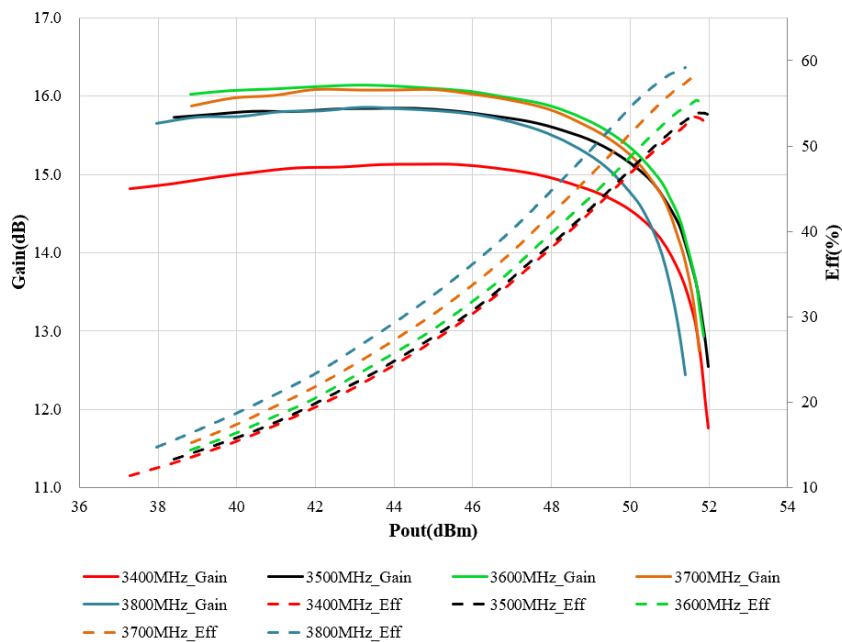




Figure 2: Network plot for S11/S21

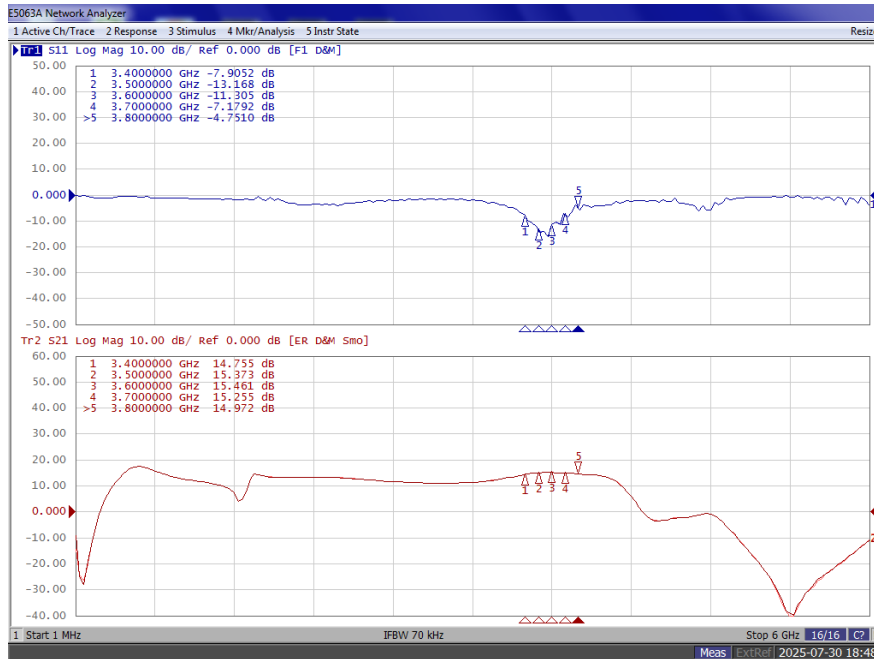


Figure 3: Picture of application board of 3.4-3.8GHz

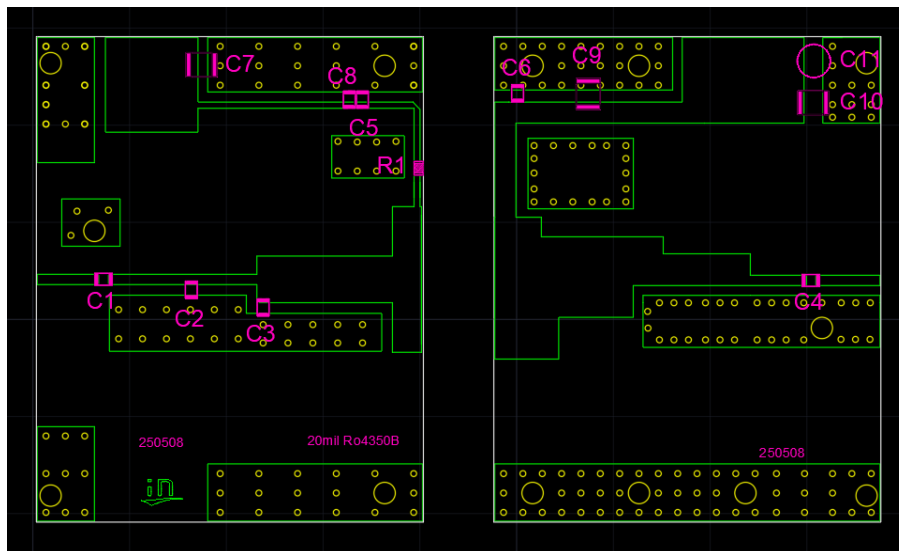


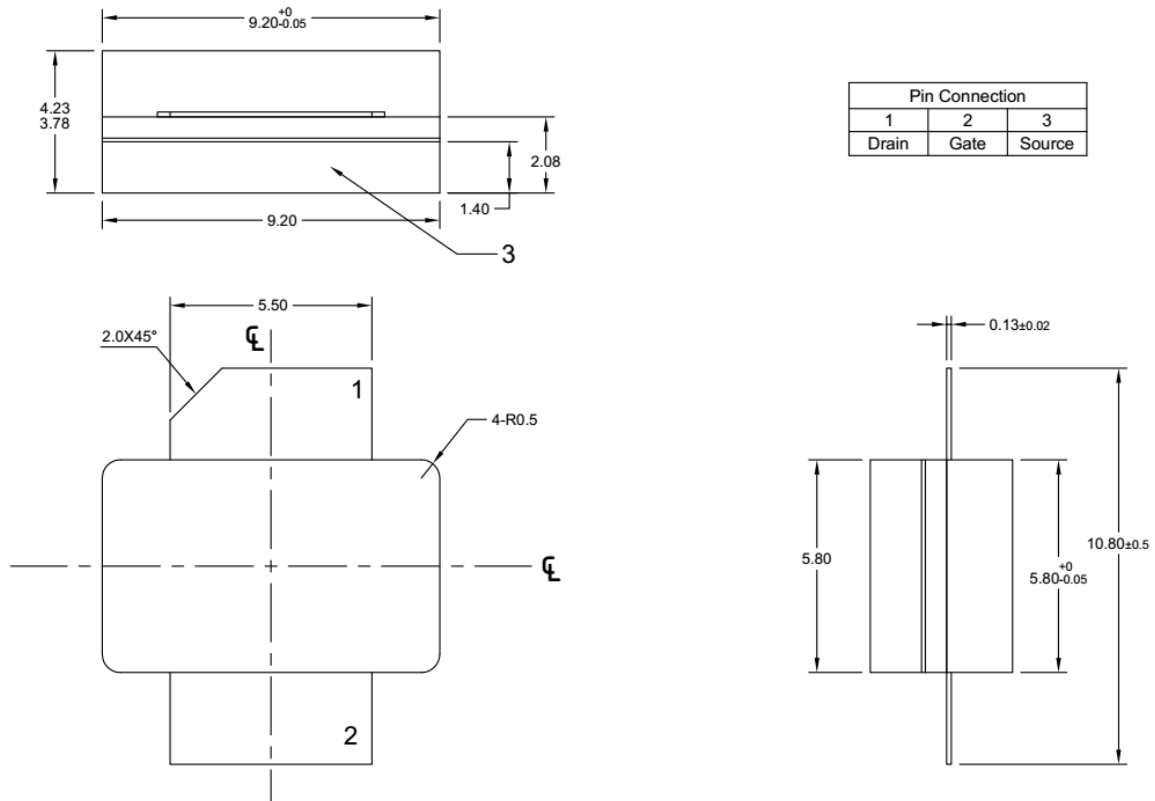
Table 4. Bill of materials of application board, RO4350B 20Mils (PCB layout upon request)

Component	Value	Quantity
U1	STBV38130G2	1
C1、 C4、 C5、 C6	8.2pF	4
C2	0.5pF	1
C3	1pF	1
C8	10nF	1
C7、 C9、 C10	10uF/63V	3
C11	470uF/63V	1
R1	10 Ω	1



Package Outline

Flanged ceramic package; 2 leads



Unit: mm

Tolerances(unless specified): x.x ±0.25

x.xx ±0.13

OUTLINE VERSION	REFERENCE			EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA		
PKG-GXB-2EL- 9.2					2018.1.31

Figure 2. Package Outline PKG-G2



Revision history

Table 4. Document revision history

Date	Revision	Datasheet Status
2025/8/1	V1.0	Preliminary Datasheet Creation

Application data based on: ZYX-25-32

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